Application/Control No. Applicant(s)/Patent Under Reexamination 10/085,381 TERADA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ahshik Kim 2876 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 02-2001 Α US-6,189,783 Motomiya et al. 235/375 US-В С US-D US-US-Ε US-F US-G US-Н 1 US-US-J US-Κ

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